

AUTOMOTIVE GRADE

AUIRLR024Z AUIRLU024Z

HEXFET® Power MOSFET

Features

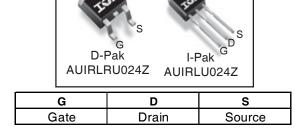
- Logic Level
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

G S

V _{(BR)DSS}	55V
R _{DS(on)} typ.	46m $Ω$
max.	58m $Ω$
I _D	16A

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low onresistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	16	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	11	Α
I _{DM}	Pulsed Drain Current ①	64	1
P _D @T _C = 25°C	Power Dissipation	35	w
	Linear Derating Factor	0.23	W/°C
V_{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	25	mJ
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value ©	25	
I _{AR}	Avalanche Current ①	See Fig.12a, 12b, 15, 16	Α
E _{AR}	Repetitive Avalanche Energy ©		mJ
T _J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	1

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		4.28	
$R_{\theta JA}$	Junction-to-Ambient (PCB mount) ②		40	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.053		V/°C	Reference to 25°C, I _D = 1mA
			46	58		$V_{GS} = 10V, I_D = 9.6A$ ③
R _{DS(on)}	Static Drain-to-Source On-Resistance			80	mΩ	$V_{GS} = 5.0V, I_D = 5.0A$ ③
				100		$V_{GS} = 4.5V, I_D = 3.0A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	1.0		3.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Transconductance	7.4			S	$V_{DS} = 25V, I_D = 9.6A$
I _{DSS}	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 55V, V_{GS} = 0V$
				250]	$V_{DS} = 55V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			200	nA	$V_{GS} = 16V$
	Gate-to-Source Reverse Leakage			-200]	V _{GS} = -16V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

-		•		•		•
	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		6.6	9.9		$I_D = 5.0A$
Q _{gs}	Gate-to-Source Charge		1.6		nC	$V_{DS} = 44V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		3.9		Ī	V _{GS} = 5.0V ③
t _{d(on)}	Turn-On Delay Time		8.2			$V_{DD} = 28V$
t _r	Rise Time		43		Ī	$I_{D} = 5.0A$
$t_{d(off)}$	Turn-Off Delay Time		19		ns	$R_G = 28 \Omega$
t _f	Fall Time		16		1	V _{GS} = 5.0V ③
L _D	Internal Drain Inductance		4.5			Between lead,
					nН	6mm (0.25in.)
L _S	Internal Source Inductance	_	7.5	_	1	from package
						and center of die contact
C _{iss}	Input Capacitance		380			$V_{GS} = 0V$
C _{oss}	Output Capacitance		62		1	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		39		pF	f = 1.0MHz
C _{oss}	Output Capacitance		180		1	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C _{oss}	Output Capacitance		50		1	$V_{GS} = 0V$, $V_{DS} = 44V$, $f = 1.0MHz$
C _{oss} eff.	Effective Output Capacitance		81		Ī	$V_{GS} = 0V$, $V_{DS} = 0V$ to 44V $\textcircled{4}$

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			16		MOSFET symbol
	(Body Diode)				Α	showing the
I _{SM}	Pulsed Source Current		_	64		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25$ °C, $I_S = 9.6A$, $V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		16	24	ns	$T_J = 25$ °C, $I_F = 9.6A$, $V_{DD} = 28V$
Q _{rr}	Reverse Recovery Charge		11	17	nC	di/dt = 100A/μs ③
t _{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 0.54mH $R_G = 25\Omega$, $I_{AS} = 9.6A$, $V_{GS} = 10V$. Part not recommended for use above this value.
- $\mbox{\ensuremath{\mathfrak{G}}}$ C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- $\ \, \ \,$ Limited by T_{Jmax} , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ® This value determined from sample failure population, starting T_J = 25°C, L = 0.54mH, R_G = 25Ω, I_{AS} = 9.6A, V_{GS} =10V.
- When mounted on 1" square PCB (FR-4 or G-10 Material) . For recommended footprint and soldering techniques refer to application note #AN-994.
- $\$ \ \ R_{\theta}$ is measured at T_J of approximately 90°C.

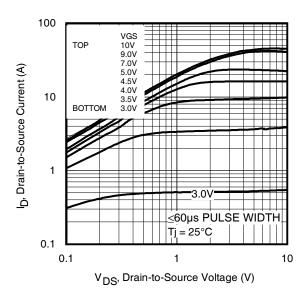
Qualification Information[†]

			Automotive		
		(per AEC-Q101) ^{††}			
Qualifica	tion Level	Comments: This part number(s) passed Automotive qualification level is grant extension of the higher Automotive level.			
Moisture Sensitivity Level		D-PAK	MSL1		
Moisture	Sensitivity Level	I-PAK	MSL1		
	Machine Model	Class M1B (+/- 100V) ^{†††}			
		AEC-Q101-002			
FOD	Human Body Model		Class H0 (+/- 250V) ^{†††}		
ESD		AEC-Q101-001			
	Charged Device	Class C5 (+/- 1125V) ^{†††}			
	Model		AEC-Q101-005		
RoHS Co	mpliant	Yes			

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

^{††} Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

^{†††} Highest passing voltage.



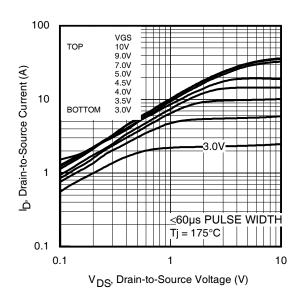
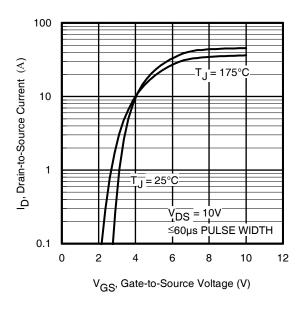


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics



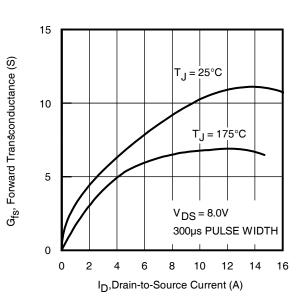
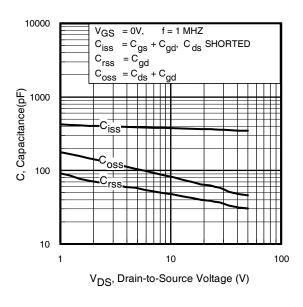


Fig 3. Typical Transfer Characteristics

Fig 4. Typical Forward Transconductance vs. Drain Current



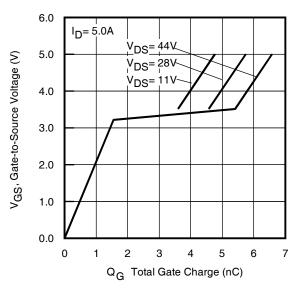
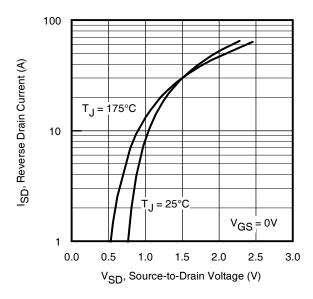


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



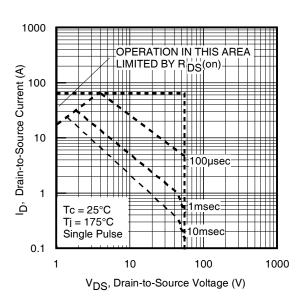
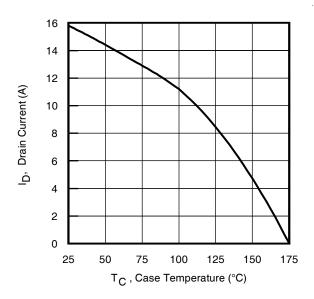


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area



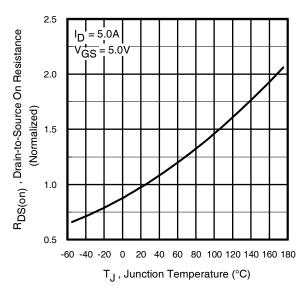


Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Normalized On-Resistance vs. Temperature

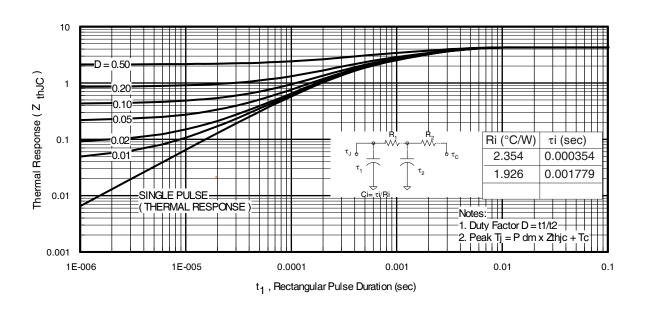


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

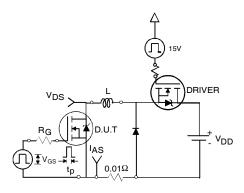


Fig 12a. Unclamped Inductive Test Circuit

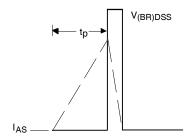


Fig 12b. Unclamped Inductive Waveforms

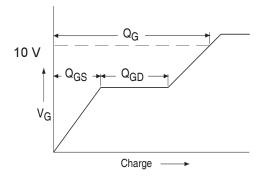
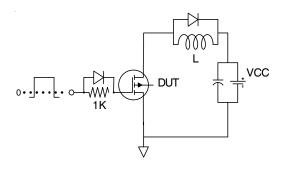


Fig 13a. Basic Gate Charge Waveform



Parting T_J, Junction Temperature (°C)

Fig 12c. Maximum Avalanche Energy vs. Drain Current

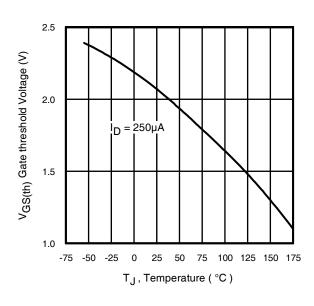


Fig 14. Threshold Voltage vs. Temperature

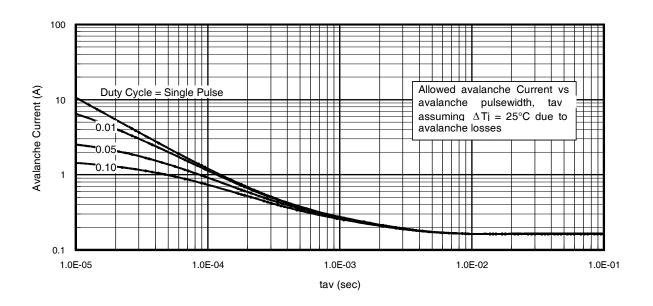


Fig 15. Typical Avalanche Current vs. Pulsewidth

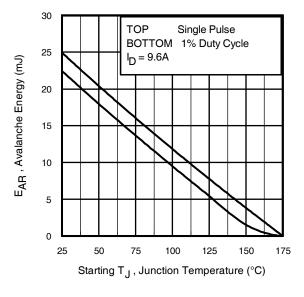


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:

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 - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long $\mbox{asT}_{\mbox{\scriptsize jmax}}$ is not exceeded.
- Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- P_{D (ave)} = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).
 - t_{av} = Average time in avalanche.
 - D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D~(ave)} &= 1/2~(~1.3 \cdot BV \cdot I_{aV}) = \triangle T/~Z_{thJC} \\ I_{av} &= 2\triangle T/~[1.3 \cdot BV \cdot Z_{th}] \\ E_{AS~(AR)} &= P_{D~(ave)} \cdot t_{av} \end{split}$$

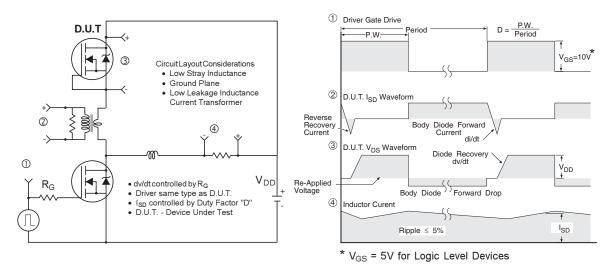


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

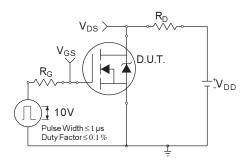


Fig 18a. Switching Time Test Circuit

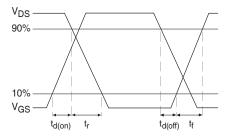
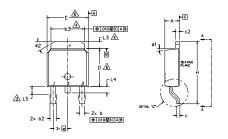
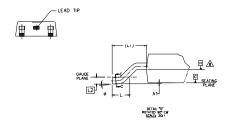


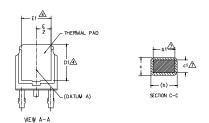
Fig 18b. Switching Time Waveforms

D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)







- NOTES:
 1.- DIMENSIONING AND TOLERANCING PER ASME Y14,5M-1994
- 2. DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 3- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10
 [0.13 AND 0.25] FROM THE LEAD TIP.

 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

_					
S		Ŋ			
Во	MILLIM	ETERS	INCHES		O T E S
0	MIN.	MAX.	MIN.	MAX.	E
A	2.18	2.39	.086	.094	
A1	_	0.13	-	.005	
ь	0.64	0.89	.025	.035	
ь1	0.65	0,79	.025	.031	7
b2	0.76	1,14	.030	.045	
ь3	4.95	5.46	.195	.215	4
С	0.46	0,61	.018	.024	
c1	0.41	0.56	.016	.022	7
¢2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
E	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
e	2.29	2.29 BSC		BSC	
н	9.40	10,41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	2.74 BSC		REF,	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1,14	1.52	.045	.060	3
ø	0*	10*	0,	10*	
ø1	0*	15*	0,	15*	
ø2	25*	35*	25*	35*	

LEAD ASSIGNMENTS

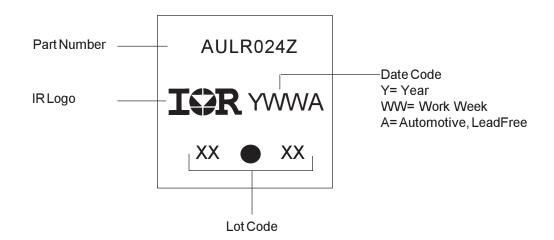
HEXFET

- 1.- GATE 2.- DRAIN
- 3.- SOURCE 4.- DRAIN

IGBT & CoPAK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

D-Pak Part Marking Information

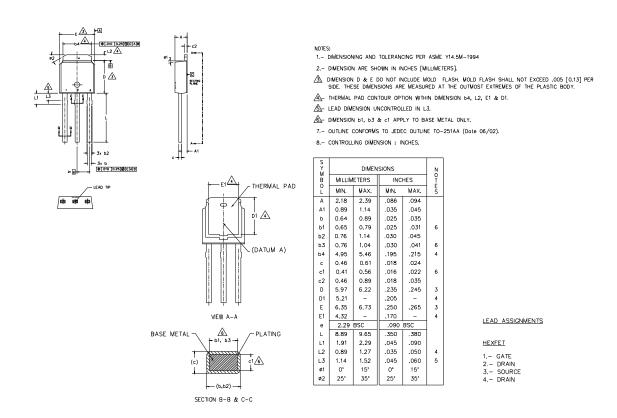


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

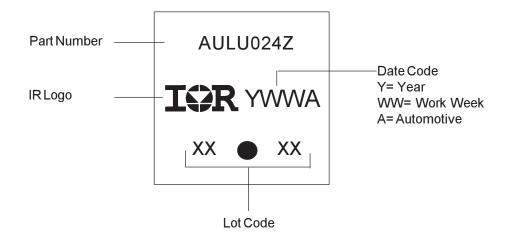
AUIRLR/U024Z

I-Pak (TO-251AA) Package Outline

Dimensions are shown in millimeters (inches)



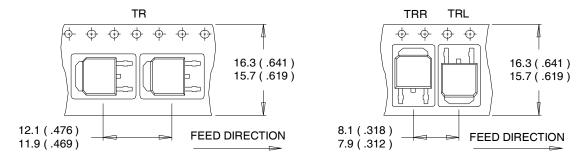
I-Pak Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

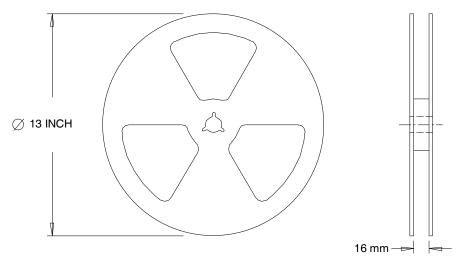
D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Ordering Information

Base part number	Package Type	Standard Pack		Standard Pack		Complete Part Number
		Form	Quantity			
AUIRLR024Z	Dpak	Tube	75	AUIRLR024Z		
		Tape and Reel	2000	AUIRLR024ZTR		
		Tape and Reel Left	3000	AUIRLR024ZTRL		
_		Tape and Reel Right	3000	AUIRLR024ZTRR		
AUIRLU024Z	lpak	Tube	75	AUIRLU024Z		

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For technical support, please contact IR's Technical Assistance Center http://www.irf.com/technical-info/

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